



SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch

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Report No.: SZEM181100950902
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Human Exposure Report

Application No.: SZEM1811009509CR
Applicant: Spigen Korea Co., Ltd.
Address of Applicant: Spigen HQ-A, 446, Bongeunsa-ro, Gangnam-gu, Seoul, 06153, South Korea
Manufacturer: Shenzhen Wireless Technolo Co., Ltd.
Address of Manufacturer: Floor 2,3 building A4, Fangxing Science and Technology park, NO. 13
Baonan Road, Longgang street, Longgang District
Factory: SHENZHEN POWERQI TECHNOLOGY Co., LTD
Address of Factory: Floor 2,3 building A4, Fangxing Science and Technology park, NO. 13
Baonan Road, Longgang street, Longgang District

Equipment Under Test (EUT):

EUT Name: Fast Wireless Charger
Model No.: F308W
FCC ID: 2AFKNF308W
Trade mark: Spigen
Standards: 47 CFR PART 1, Subpart I, Section 1.1310
Date of Receipt: 2018-11-01
Date of Test: 2018-11-01 to 2018-11-07
Date of Issue: 2018-11-07

Test Result :	Pass*
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* In the configuration tested, the EUT complied with the standards specified above



Keny Xu
EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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2 General Information

2.1 Details of E.U.T.

Power supply: Input: DC 9V, 1.67A
Output: 5W/7.5W/10W

Cable: USB charging line: 40cm, unshielded

Antenna Type: Inductive Loop Coil Antenna

Modulation Type: Load Modulation

Operation Frequency: 109.29kHz to 168.59kHz

Remark: Tests were conducted in all three load modes and the worst case(10W) is reported only.

2.2 Description of Support Units

Description	Manufacturer	Model No.	Serial No.
Adapter	Apple	A1357 W010A051	REF. No.SEA0500
Adapter	SAMSUNG	EP-TA200	R37J8YA7W71DK3
iPhone 8	Apple	A1863	F4GVQ656JC6D
Mobile Phone	SAMSUNG	SM-G9500	R28J9140LPB



2.3 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch E&E Lab,

No. 1 Workshop, M-10, Middle section, Science & Technology Park, Shenzhen, Guangdong, China 518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

2.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **CNAS (No. CNAS L2929)**

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

- **A2LA (Certificate No. 3816.01)**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation (A2LA). Certificate No. 3816.01.

- **VCCI**

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

- **FCC –Designation Number: CN1178**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

- **Innovation, Science and Economic Development Canada**

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized by ISED as an accredited testing laboratory.

CAB identifier: CN0006.

IC#: 4620C.



2.5 Deviation from Standards

None.

2.6 Abnormalities from Standard Conditions

None.

3 Equipments Used during Test

Item	Test Equipment	Manufacturer	Model No.	Inventory No.	Cal. Due date (yyyy-mm-dd)
1	Shielding Room	SAEMC	MSR733	SEM001-09	2020-05-09
2	Electric and Magnetic Field Analyzer	Narda	EHP-50F	EMC092	2019-02-06



4 Test Results

4.1 RF Exposure test

Test Requirement: 47 CFR PART 1, Subpart I, Section 1.1310

Measurement Distance: 15cm

Limit:

Frequency range (MHz)	Electric field strength (V/m)	Magnetic field strength (A/m)	Power density (mW/cm ²)	Averaging time (minutes)
(A) Limits for Occupational/Controlled Exposures				
0.3-3.0	614	1.63	*(100)	6
3.0-30	1842/f	4.89/f	*(900/f ²)	6
30-300	61.4	0.163	1.0	6
300-1500	/	/	f/300	6
1500-100,000	/	/	5	6
(B) Limits for General Population/Uncontrolled Exposure				
0.3-1.34	614	1.63	*(100)	30
1.34-30	824/f	2.19/f	*(180/f ²)	30
30-300	27.5	0.073	0.2	30
300-1500	/	/	f/1500	30
1500-100,000	/	/	1.0	30
F=frequency in MHz *=Plane-wave equivalent power density RF exposure compliance will need to be determined with respect to 1.1307(c) and (d) of the FCC rules. The emissions should be within the limits at 300kHz in Table 1 of 1.1310(use the 300kHz limits for 150kHz:614V/m,1.63A/m).				

4.1.1 E.U.T. Operation

Operating Environment:

Temperature: 25.0 °C Humidity: 52% RH Atmospheric Pressure: 1015 mbar

EUT Operation:

This device has been tested the worst status of full load and the device has been tested with load at zero charge, intermediate charge, and full charge.



4.1.2 Measurement Data

Output Voltage=DC 9V; The max output power =10W;Calculation of resistor value=8.1Ω

Electric Field Emissions

Operation frequency	Test Distance (cm)	Test Position	Probe Measure Result (V/m)	50% Limit (V/m)
147.2 kHz	15	Side 1	1.51	307
		Side 2	1.37	307
		Side 3	1.42	307
		Side 4	1.19	307
		Top	1.83	307

Magnetic Field Emissions

Operation frequency	Test Distance (cm)	Test Position	Probe Measure Result (A/m)	50% Limit (A/m)
147.2 kHz	15	Side 1	0.0432	0.815
		Side 2	0.0331	0.815
		Side 3	0.0405	0.815
		Side 4	0.0326	0.815
		Top	0.0523	0.815

Electric Field Emissions

Operation frequency	Test Distance (cm)	Test Position	Probe Measure Result(V/m)			50%Limit (V/m)
			zero charge	intermediate charge	full charge	
147.2 kHz	15	Side 1	1.47	1.44	1.43	307
		Side 2	1.37	1.36	1.28	307
		Side 3	1.46	1.38	1.34	307
		Side 4	1.22	1.12	1.19	307
		Top	1.85	1.87	1.81	307

Magnetic Field Emissions

Operation frequency	Test Distance (cm)	Test Position	Probe Measure Result(A/m)			50%Limit (A/m)
			zero charge	intermediate charge	full charge	
147.2 kHz	15	Side 1	0.0437	0.0421	0.0453	0.815
		Side 2	0.0325	0.0296	0.0298	0.815
		Side 3	0.0411	0.0392	0.0405	0.815
		Side 4	0.0332	0.0316	0.0327	0.815
		Top	0.0518	0.0504	0.0497	0.815

5 Photographs- RF exposure Setup photos

Refer to setup photos.

- End of the Report -